

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Paul Alexander DE VRIES et al.

Serial No.: To be assigned

(National Phase of PCT/EP2003/006901)

Filed: December 3, 2004

For: METHOD FOR FRACTIONAL CRYSTALLISATION OF A MOLTEN METAL

## INFORMATION DISCLOSURE STATEMENT

Mail Stop Patent Application Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to Rules 56 and 98, Applicants hereby call the attention of the Patent Office to the references listed on the attached Form PTO 1449. These references were cited in an International Search Report (copy enclosed) in a corresponding International Application.

Applicants present these references so that the Patent Office may, in the first instance, determine any relevancy thereof to the presently claimed invention, see <u>Beckman Instruments</u>, <u>Inc. v. Chemtronics</u>, <u>Inc.</u>, 439 F.2d 1369, 1380, 165 USPQ 355, 364 (5th Cir. 1970). Also see Patent Office Rule 104. Applicants respectfully request that these references be expressly considered during the prosecution of this application and made of record herein and appear among the "Reference Cited" on any patent to issue herefrom.

By:

Respectfully submitted,

APV/kag

ATTORNEY DOCKET NO. APV31833

Date: Dec. 3, 2004

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DTO Rec'd PCT/PTO 0 3 APE 20041

FORM PTO-1449 U.S. Department of Commerce (Rev. 4/92) Patent and Trademark Office

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

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**APPLICANT** 

Paul Alexander DE VRIES et al.

FILING DATE

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GROUP

## **U.S. PATENT DOCUMENTS**

EXAMINER INITIAL			DOCU	MENT NU	MBER			DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	3	6	7	1	2	2	9	06/72	Ferber et al.			
	4	2	3	9	6	0	6	12/80	Dawless et al.			
	4	7	4	4	8	2	3	05/88	Raymond-Seraille			
												•

## FOREIGN PATENT DOCUMENTS

			DOCU	MENT N	JMBER			DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
	·											YES	NO
		6	1	5	5	9	0	01/49	GB				
	1	5	9	4	1	5	4	06/70	FR			Abstract Only	
	0	3	7	5	3	0	8	06/90	EP				
5	8	1	0	4	1	3	2	06/83	JP			Abstract Only	
5	9	0	2	8	5	3	8	02/84	JP			Abstract Only	
 5	7	1	5	2	4	3	5	09/82	JP			Abstract Only	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

PATENT ABSTRACT OF JAPAN vol. 007, no. 205 (C-185), 9 September 1983 (1983-09-09)
 PATENT ABSTRACT OF JAPAN vol. 008, no. 114 (C-225), 26 May 1984 (1984-05-26)
PATENT ABSTRACT OF JAPAN vol. 006, no. 257 (C-140), 16 December 1982 (1982-12-16)

EXAMINER DATE CONSIDERED

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.